FAIRCHILD SEMICONDUCTOR®

February 2014

FDMC86259P

P-Channel PowerTrench® MOSFET

-150 V, -13 A, 107 mΩ

Features

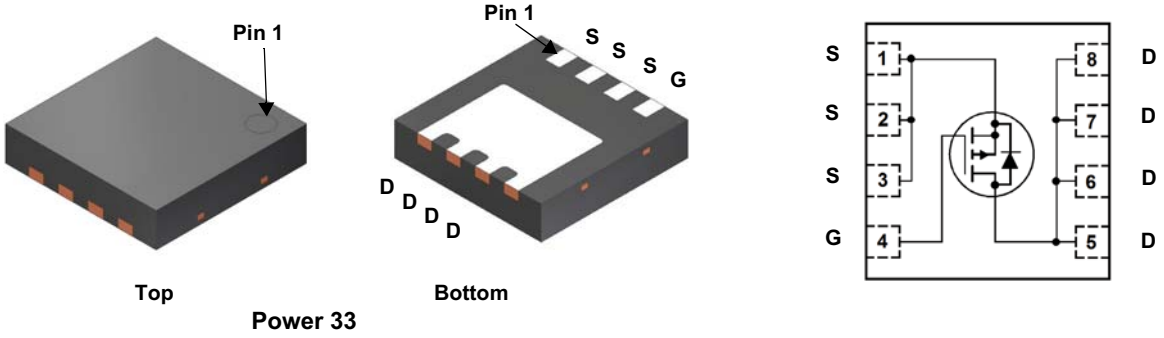
- Max $r_{DS(on)}$ = 107 mΩ at V_{GS} = -10 V, I_D = -3 A
- Max $r_{DS(on)}$ = 137 mΩ at V_{GS} = -6 V, I_D = -2.7 A
- Very low RDS-on mid voltage P channel silicon technology optimised for low Qg
- This product is optimised for fast switching applications as well as load switch applications
- 100% UIL Tested
- RoHS Compliant

General Description

This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Applications

- Active Clamp Switch
- Load Switch



Top Bottom

Power 33

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			-150	V
V_{GS}	Gate to Source Voltage			±25	V
I_D	Drain Current -Continuous	T_C = 25 °C		-13	A
	-Continuous	T_A = 25 °C	(Note 1a)	-3.2	
	-Pulsed			-20	
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	181	mJ
P_D	Power Dissipation	T_C = 25 °C		62	W
	Power Dissipation	T_A = 25 °C	(Note 1a)	2.3	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to + 150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

Package Marking and Ordering Information

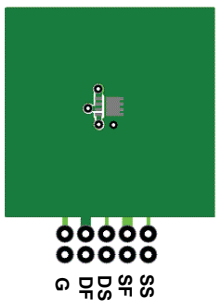
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86259P	FDMC86259P	Power 33	13"	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = -250 μA, V_{GS} = 0 V	-150			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, referenced to 25 °C		-88		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = -120 V, V_{GS} = 0 V			-1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±25 V, V_{DS} = 0 V			±100	nA
On Characteristics						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = -250 μA	-2	-2.8	-4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μA, referenced to 25 °C		6		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = -10 V, I_D = -3 A		87	107	mΩ
		V_{GS} = -6 V, I_D = -2.7 A		99	137	
		V_{GS} = -10 V, I_D = -3 A,T_J = 125 °C		145	178	
g_{FS}	Forward Transconductance	V_{DS} = -10 V, I_D = -3 A		12		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = -75 V, V_{GS} = 0 V, f = 1 MHz		1535	2045	pF
C_{oss}	Output Capacitance			125	170	pF
C_{rss}	Reverse Transfer Capacitance			6	10	pF
R_g	Gate Resistance		0.1	1.4	3	Ω
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = -75 V, I_D = -3 A, V_{GS} = -10 V, R_{GEN} = 6 Ω		12	23	ns
t_r	Rise Time			3.3	10	ns
$t_{d(off)}$	Turn-Off Delay Time			22	36	ns
t_f	Fall Time			9.6	20	ns
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to -10 V; V_{DD} = -75 V, I_D = -3 A		22	32	nC
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to -6 V; V_{DD} = -75 V, I_D = -3 A		14	20	nC
Q_{gs}	Total Gate Charge	V_{DD} = -75 V, I_D = -3 A		5.7		nC
Q_{gd}	Gate to Drain “Miller” Charge	V_{DD} = -75 V, I_D = -3 A		4.3		nC
Drain-Source Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = -3 A (Note 2)		-0.80	-1.3	V
		V_{GS} = 0 V, I_S = -1.9 A (Note 2)		-0.78	-1.2	V
t_{rr}	Reverse Recovery Time	I_F = -3 A, di/dt = 100 A/μs		77	123	ns
Q_{rr}	Reverse Recovery Charge			208	333	nC

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 53 °C/W when mounted on a 1 in^2 pad of 2 oz copper

b) 125 °C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

3. Starting T_J = 25 °C; P-ch: L = 3 mH, I_{AS} = -11 A, V_{DD} = -150 V, V_{GS} = -10 V. 100% test at L = 0.1 mH, I_{AS} = -34 A.

Typical Characteristics T_J = 25 °C unless otherwise noted

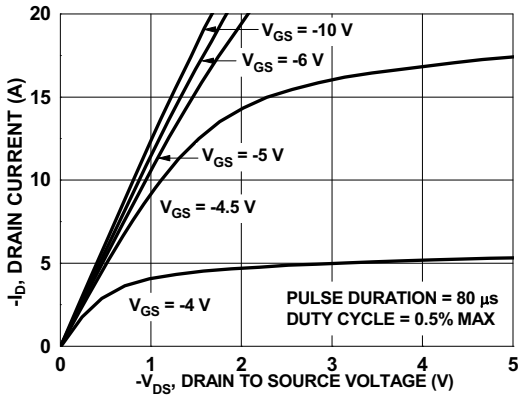


Figure 1. On Region Characteristics

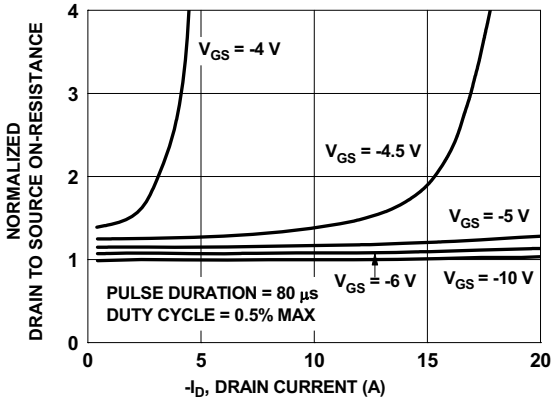


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

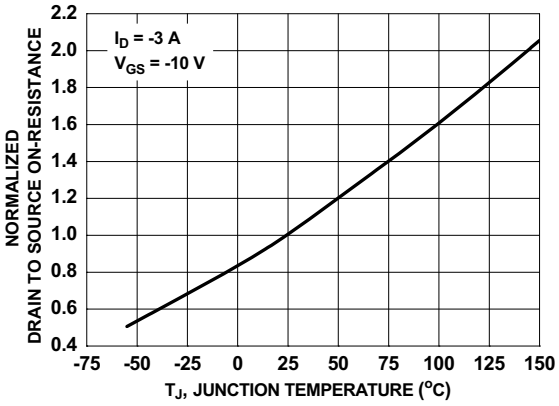


Figure 3. Normalized On Resistance vs Junction Temperature

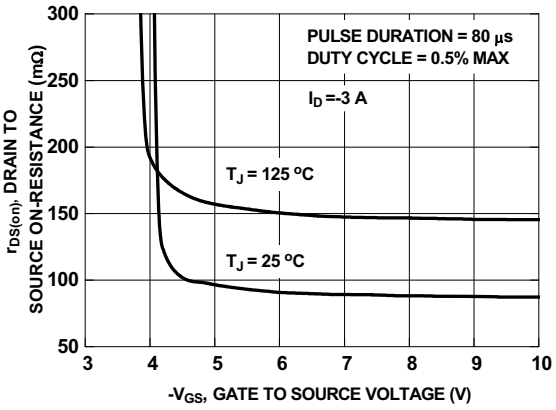


Figure 4. On-Resistance vs Gate to Source Voltage

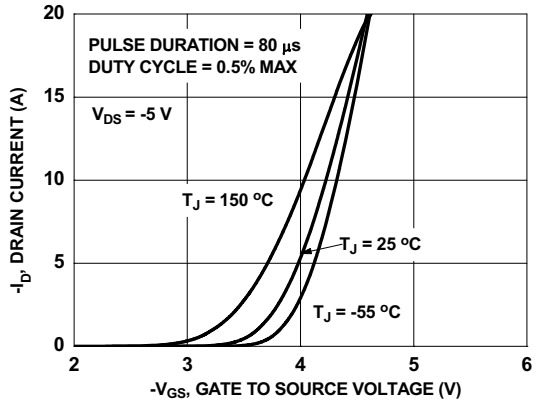


Figure 5. Transfer Characteristics

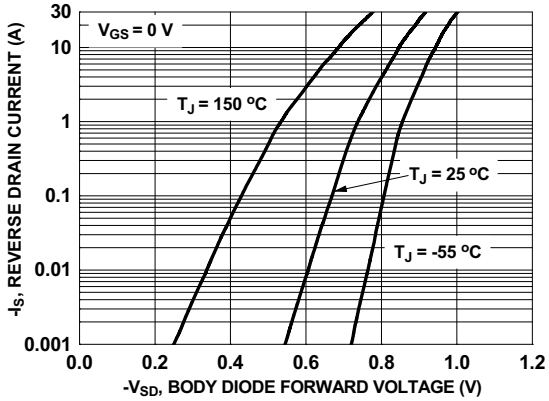


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

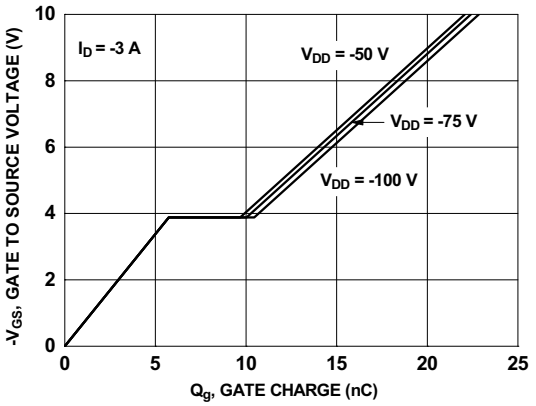


Figure 7. Gate Charge Characteristics

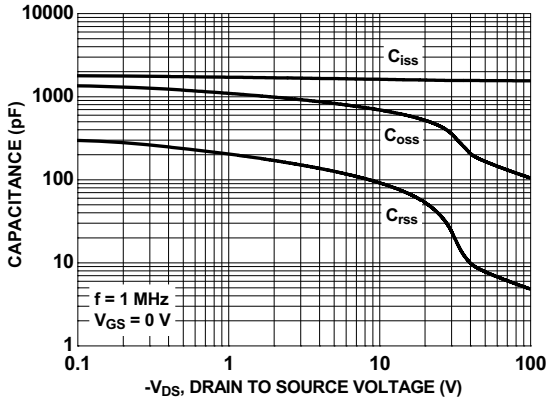


Figure 8. Capacitance vs Drain to Source Voltage

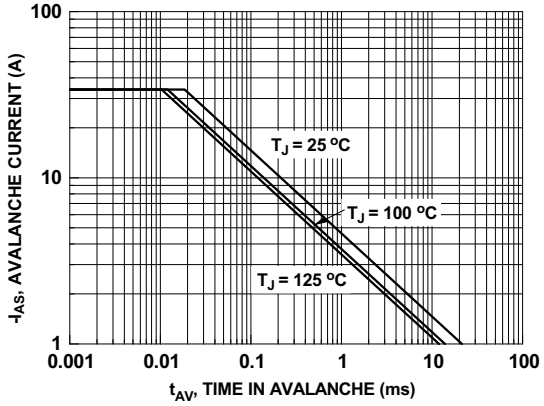


Figure 9. Unclamped Inductive Switching Capability

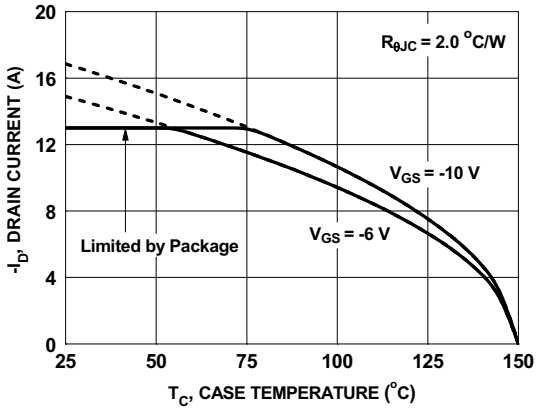


Figure 10. Maximum Continuous Drain Current vs Case Temperature

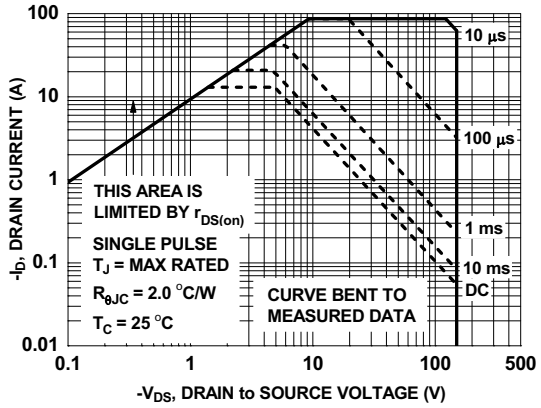


Figure 11. Forward Bias Safe Operating Area

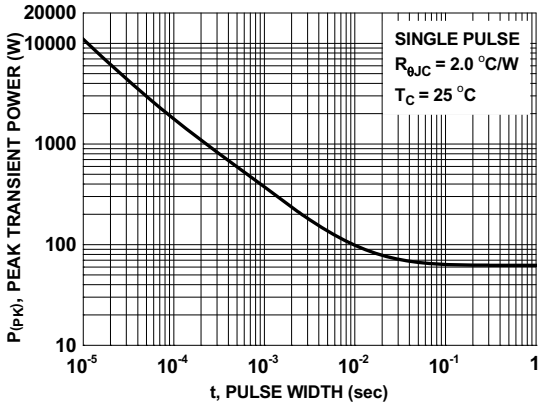


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

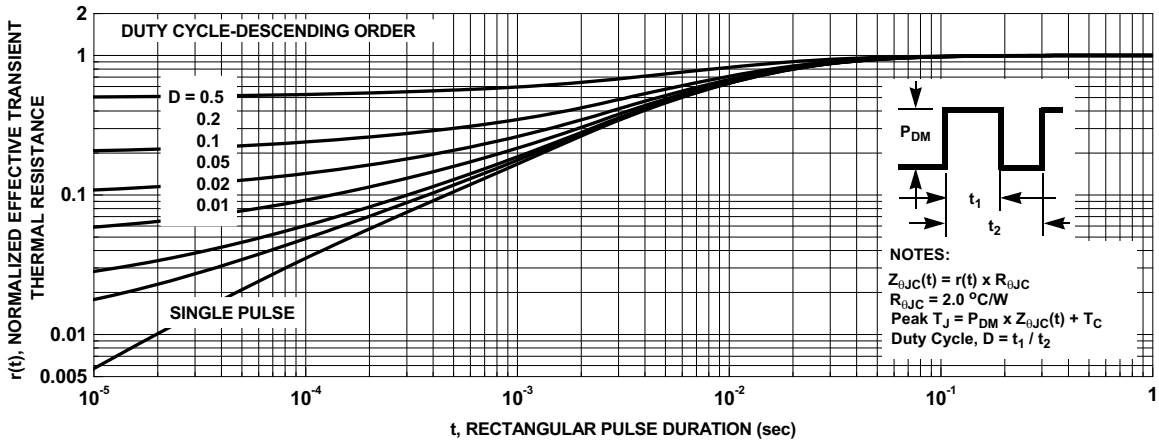
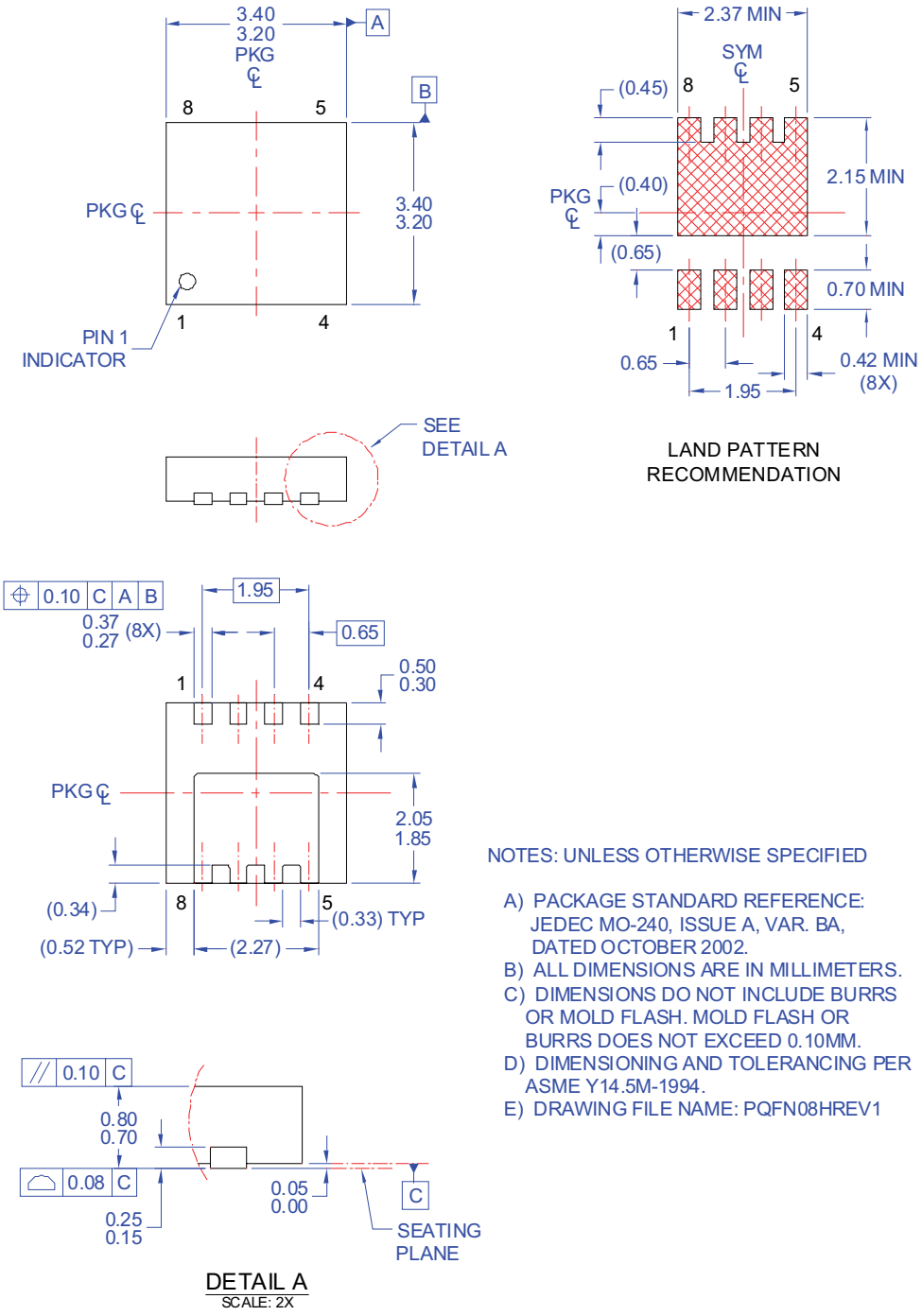


Figure 13. Junction-to-Case Transient Thermal Response Curve

Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED

A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
E) DRAWING FILE NAME: PQFN08HREV1

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